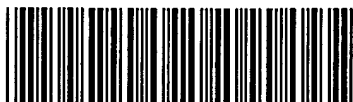


Search Notes

Application/Control No.

10/523,352

Examiner

Hai L. Nguyen

Applicant(s)/Patent under
Reexamination

MIZUNO ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	100, 102	8/17/2006	HLN
327	58,91,94	8/18/2006	HLN
341	122	8/19/2006	HLN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search; see search history printout	8/18/2006	HLN
EAST Search; see search history printout	8/18/2006	HLN
Shepardize Search; see search history printout	8/19/2006	HLN